

10024850
10/14/2001

PATENT NUMBER and
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10024850	12/19/2001	257		2823	coleman

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**CONTINUING DATA VERIFIED:

THIS APPLICATION IS A CON OF 08/951,819 10/14/1997 NOW U. S. PATENT 6,365,933

** FOREIGN APPLICATIONS VERIFIED:

JAPAN 8-294419 10/15/1996

JAPAN 8-301250 10/24/1996

PG-PUB	DO NOT PUBLISH <input type="checkbox"/>	RESCIND <input type="checkbox"/>	
Foreign priority claimed		<input type="checkbox"/> yes <input type="checkbox"/> no	ATTORNEY DOCKET NO
35 USC 119 conditions met		<input type="checkbox"/> yes <input type="checkbox"/> no	07977-188002/US3427/3434D
Verified and Acknowledged Examiners's initials			
TITLE : Semiconductor device and method of manufacturing the same			
U.S. DEPT. OF COMM /PAT & TM-PTO-436L (Rev. 12-94)			

NOTICE OF ALLOWANCE MAILED		Assistant Examiner	CLAIMS ALLOWED	
			Total Claims	Print Claim for O.G
ISSUE FEE		DRAWING		
Amount Due	Date Paid	Sheets Drwg.	Figs.Drwg.	Print Fig.
TERMINAL		Primary Examiner		
DISCLAIMER		Application Examiner		
PREPARED FOR ISSUE				
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